Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/676,307	BANERJEE ET AL.	
Examiner	Art Unit	
David Mis	2817	

SEARCHED				
Class	Subclass	Date	Examiner	
331	36C, 108C,	3/22/2005	DM	
	117R,			
	117FE,			
	117D,			
	175,			
	177R,			
	177V			
257	18, 19,			
	192			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMF		
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